	Application No.	10/822,424
INFORMATION DISCLOSURE	Filing Date	April 12, 2004
STATEMENT BY APPLICANT	First Named Inventor	Bulent M. Basol
STATEMENT BY APPLICANT	Art Unit	1742 1795
(Multiple sheets used when necessary)	Examiner	Zulmariam Mendez
SHEET 1 OF 2	Attorney Docket No.	NVLUS.029CP1(5296)

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Examiner Initials	Cite No. Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.		T ¹	
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Examiner Signature	/Zulmariam Mendez/	Date Considered	10/28/2007		
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PTO/SB/08 Equivalent

Application No. 10/822,424 INFORMATION DISCLOSURE Filing Date April 12, 2004 First Named Inventor Bulent M. Basol STATEMENT BY APPLICANT 1795 Art Unit 1742 (Multiple sheets used when necessary) Examiner Zulmariam Mendez SHEET 2 OF 2 Attorney Docket No. NVLUS.029CP1(5296)

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Examiner Signature	/Zulmariam Mendez/	Date Considered	10/28/2007
			

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